

## EXTENDED COMMON-MODE RS-485 TRANSCEIVERS

### FEATURES

- **Common-Mode Voltage Range (–20 V to 25 V)  
More Than Doubles TIA/EIA-485 Requirement**
- **Receiver Equalization Extends Cable Length,  
Signaling Rate (HVD23, HVD24)**
- **Reduced Unit-Load for up to 256 Nodes**
- **Bus I/O Protection to Over 16-kV HBM**
- **Failsafe Receiver for Open-Circuit,  
Short-Circuit and Idle-Bus Conditions**
- **Low Standby Supply Current 1- $\mu$ A Max**
- **More Than 100 mV Receiver Hysteresis**

### APPLICATIONS

- **Long Cable Solutions**
  - Factory Automation
  - Security Networks
  - Building HVAC
- **Severe Electrical Environments**
  - Electrical Power Inverters
  - Industrial Drives
  - Avionics

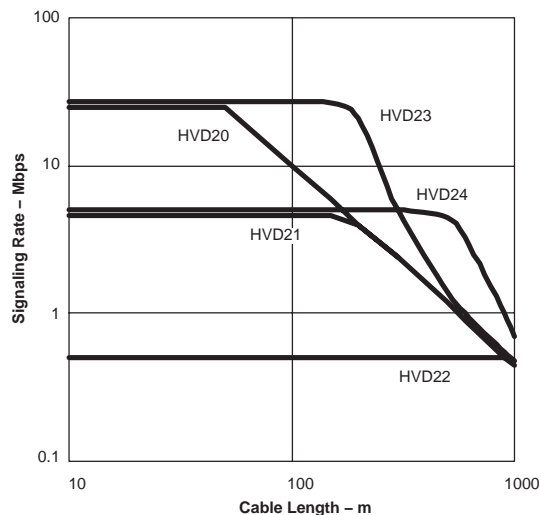
### DESCRIPTION

The transceivers in the HVD2x family offer performance far exceeding typical RS-485 devices. In addition to meeting all requirements of the TIA/EIA-485-A standard, the HVD2x family operates over an extended range of common-mode voltage, and has features such as high ESD protection, wide receiver hysteresis, and failsafe operation. This family of devices is ideally suited for long-cable networks, and other applications where the environment is too harsh for ordinary transceivers.

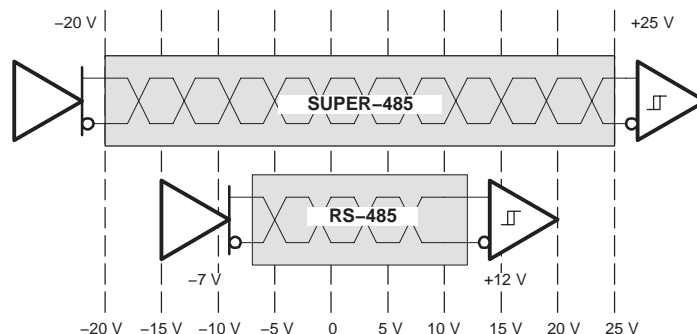
These devices are designed for bidirectional data transmission on multipoint twisted-pair cables. Example applications are digital motor controllers, remote sensors and terminals, industrial process control, security stations, and environmental control systems.

These devices combine a 3-state differential driver and a differential receiver, which operate from a single 5-V power supply. The driver differential outputs and the receiver differential inputs are connected internally to form a differential bus port that offers minimum loading to the bus. This port features an extended common-mode voltage range making the device suitable for multipoint applications over long cable runs.

HVD2x APPLICATION SPACE



HVD2x Devices Operate Over a Wider Common-Mode Voltage Range



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

# SN65HVD20, SN65HVD21 SN65HVD22, SN65HVD23, SN65HVD24

SLLS552D – DECEMBER 2002 – REVISED APRIL 2005



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

## DESCRIPTION (continued)

The 'HVD20 provides high signaling rate (up to 25 Mbps) for interconnecting networks of up to 64 nodes.

The 'HVD21 allows up to 256 connected nodes at moderate data rates (up to 5 Mbps). The driver output slew rate is controlled to provide reliable switching with shaped transitions which reduce high-frequency noise emissions.

The 'HVD22 has controlled driver output slew rate for low radiated noise in emission-sensitive applications and for improved signal quality with long stubs. Up to 256 'HVD22 nodes can be connected at signaling rates up to 500 kbps.

The 'HVD23 implements receiver equalization technology for improved jitter performance on differential bus applications with data rates up to 25 Mbps at cable lengths up to 160 meters.

The 'HVD24 implements receiver equalization technology for improved jitter performance on differential bus applications with data rates in the range of 1 Mbps to 10 Mbps at cable lengths up to 1000 meters.

The receivers also include a failsafe circuit that provides a high-level output within 250 microseconds after loss of the input signal. The most common causes of signal loss are disconnected cables, shorted lines, or the absence of any active transmitters on the bus. This feature prevents noise from being received as valid data under these fault conditions. This feature may also be used for Wired-Or bus signaling.

The SN65HVD2X devices are characterized for operation over the temperature range of  $-40^{\circ}\text{C}$  to  $85^{\circ}\text{C}$ .

## PRODUCT SELECTION GUIDE

PART NUMBERS	CABLE LENGTH AND SIGNALING RATE <sup>(1)</sup>	NODES	MARKING
SN65HVD20	Up to 50 m at 25 Mbps	Up to 64	D: VP20 P: 65HVD20
SN65HVD21	Up to 150 m at 5 Mbps (with slew rate limit)	Up to 256	D: VP21 P: 65HVD21
SN65HVD22	Up to 1200 m at 500 kbps (with slew rate limit)	Up to 256	D: VP22 P: 65HVD22
SN65HVD23	Up to 160 m at 25 Mbps (with receiver equalization)	Up to 64	D: VP23 P: 65HVD23
SN65HVD24	Up to 500 m at 3 Mbps (with receiver equalization)	Up to 256	D: VP24 P: 65HVD24

<sup>(1)</sup> Distance and signaling rate predictions based upon Belden 3105A cable and 15% eye pattern jitter.

## AVAILABLE OPTIONS

PLASTIC THROUGH-HOLE P-PACKAGE (JEDEC MS-001)	PLASTIC SMALL-OUTLINE <sup>(1)</sup> D-PACKAGE (JEDEC MS-012)
SN65HVD20P SN65HVD21P SN65HVD22P SN65HVD23P SN65HVD24P	SN65HVD20D SN65HVD21D SN65HVD22D SN65HVD23D SN65HVD24D

<sup>(1)</sup> Add R suffix for taped and reeled carriers.

**DRIVER FUNCTION TABLE**

HVD20, HVD21, HVD22				HVD23, HVD24			
INPUT	ENABLE	OUTPUTS		INPUT	ENABLE	OUTPUTS	
D	DE	A	B	D	DE	A	B
H	H	H	L	H	H	H	L
L	H	L	H	L	H	L	H
X	L	Z	Z	X	L	Z	Z
X	OPEN	Z	Z	X	OPEN	Z	Z
OPEN	H	H	L	OPEN	H	L	H

H = high level, L = low level, X = don't care, Z = high impedance (off), ? = indeterminate

**RECEIVER FUNCTION TABLE**

DIFFERENTIAL INPUT $V_{ID} = (V_A - V_B)$	ENABLE $\overline{RE}$	OUTPUT R
$0.2\text{ V} \leq V_{ID}$	L	H
$-0.2\text{ V} < V_{ID} < 0.2\text{ V}$	L	H (see Note A)
$V_{ID} \leq -0.2\text{ V}$	L	L
X	H	Z
X	OPEN	Z
Open circuit	L	H
Short Circuit	L	H
Idle (terminated) bus	L	H

H = high level, L = low level, Z = high impedance (off)

NOTE A: If the differential input  $V_{ID}$  remains within the transition range for more than 250  $\mu\text{s}$ , the integrated failsafe circuitry detects a bus fault, and set the receiver output to a high state. See Figure 15.

## ABSOLUTE MAXIMUM RATINGS

over operating free-air temperature range unless otherwise noted<sup>(1)</sup>

			SN65HVD2X
Supply voltage <sup>(2)</sup> , V <sub>CC</sub>			–0.5 V to 7 V
Voltage at any bus I/O terminal			–27 V to 27 V
Voltage input, transient pulse, A and B, (through 100 Ω, see Figure 16)			–60 V to 60 V
Voltage input at any D, DE or $\overline{RE}$ terminal			–0.5 V to V <sub>CC</sub> + 0.5 V
Receiver output current, I <sub>O</sub>			–10 mA to 10 mA
Electrostatic discharge	Human Body Model <sup>(3)</sup>	A, B, GND	16 kV
		All pins	5 kV
	Charged-Device Model <sup>(4)</sup>	All pins	1.5 kV
		Machine Model <sup>(5)</sup>	All pins
Continuous total power dissipation			See Power Dissipation Rating Table
Junction temperature, T <sub>J</sub>			150°C

(1) Stresses beyond those listed under “absolute maximum ratings” may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under “recommended operating conditions” is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) All voltage values, except differential I/O bus voltages, are with respect to network ground terminal.

(3) Tested in accordance with JEDEC Standard 22, Test Method A114-A.

(4) Tested in accordance with JEDEC Standard 22, Test Method C101.

(5) Tested in accordance with JEDEC Standard 22, Test Method A115-A.

# SN65HVD20, SN65HVD21 SN65HVD22, SN65HVD23, SN65HVD24

SLLS552D – DECEMBER 2002 – REVISED APRIL 2005

## POWER DISSIPATION RATINGS

PACKAGE	CIRCUIT BOARD MODEL	$T_A \leq 25^\circ\text{C}$ POWER RATING	DERATING FACTOR <sup>(3)</sup> ABOVE $T_A = 25^\circ\text{C}$	$T_A = 70^\circ\text{C}$ POWER RATING	$T_A = 85^\circ\text{C}$ POWER RATING
D	Low-K <sup>(1)</sup>	577 mW	4.62 mW/°C	369 mW	300 mW
	High-K <sup>(2)</sup>	913 mW	7.3 mW/°C	584 mW	474 mW
P	Low-K <sup>(1)</sup>	984 mW	7.87 mW/°C	630 mW	512 mW
	High-K <sup>(2)</sup>	1344 mW	10.8 mW/°C	860 mW	700 mW

(1) In accordance with the Low-K thermal metric definitions of EIA/JESD51–3.

(2) In accordance with the High-K thermal metric definitions of EIA/JESD51–7.

(3) This is the inverse of the junction-to-ambient thermal resistance when board-mounted and with no air flow.

## THERMAL CHARACTERISTICS

PARAMETER			TEST CONDITIONS		VALUE	UNITS	
$\theta_{JB}$	Junction-to-board thermal resistance	D			86.2	$^{\circ}\text{C/W}$	
		P			56		
$\theta_{JC}$	Junction-to-case thermal resistance	D			47.1		
		P			54		
$P_D$	Device power dissipation	Typical	HVD20	$V_{CC} = 5\text{ V}$ , $T_J = 25^{\circ}\text{C}$ , $R_L = 54\ \Omega$ , $C_L = 50\text{ pF}$ (driver), $C_L = 15\text{ pF}$ (receiver), 50% Duty cycle square-wave signal, Driver and receiver enabled	25 Mbps	295	mW
			HVD21		5 Mbps	260	
			HVD22		500 kbps	233	
			HVD23		25 Mbps	302	
			HVD24		5 Mbps	267	
	Worst case	HVD20	$V_{CC} = 5.5\text{ V}$ , $T_J = 125^{\circ}\text{C}$ , $R_L = 54\ \Omega$ , $C_L = 50\text{ pF}$ , $C_L = 15\text{ pF}$ (receiver), 50% Duty cycle square-wave signal, Driver and receiver enabled	25 Mbps	408		
		HVD21		5 Mbps	342		
		HVD22		500 kbps	300		
		HVD23		25 Mbps	417		
		HVD24		5 Mbps	352		
$T_{SD}$ Thermal shut-down junction temperature					170	$^{\circ}\text{C}$	

## RECOMMENDED OPERATING CONDITIONS

		MIN	NOM	MAX	UNIT
Supply voltage, V <sub>CC</sub>		4.5	5	5.5	V
Voltage at any bus I/O terminal	A, B	−20		25	V
High-level input voltage, V <sub>IH</sub>	D, DE, $\overline{RE}$	2	V <sub>CC</sub>		V
Low-level input voltage, V <sub>IL</sub>		0	0.8		
Differential input voltage, V <sub>ID</sub>	A with respect to B	−25		25	V
Output current	Driver	−110		110	mA
	Receiver	−8		8	
Operating free-air temperature, T <sub>A</sub> <sup>(1)</sup>		−40		85	°C
Junction temperature, T <sub>J</sub>		−40		130	°C

(1) Maximum free-air temperature operation is allowed as long as the device recommended junction temperature is not exceeded.

## DRIVER ELECTRICAL CHARACTERISTICS

over recommended operating conditions (unless otherwise noted)<sup>(1)</sup>

PARAMETER	TEST CONDITIONS	MIN	TYP <sup>(1)</sup>	MAX	UNIT
V <sub>IK</sub>	Input clamp voltage I <sub>I</sub> = -18 mA	-1.5	0.75		V
V <sub>O</sub>	Open-circuit output voltage A or B, No load	0		V <sub>CC</sub>	V
V <sub>OD(SS)</sub>	No load (open circuit)	3.3	4.2	V <sub>CC</sub>	V
	R <sub>L</sub> = 54 Ω, See Figure 1	1.8	2.5		
	With common-mode loading, See Figure 2	1.8			
Δ V <sub>OD(SS)</sub>	Change in steady-state differential output voltage between logic states See Figure 1 and Figure 3	-0.1		0.1	V
V <sub>OC(SS)</sub>	Steady-state common-mode output voltage See Figure 1	2.1	2.5	2.9	V
ΔV <sub>OC(SS)</sub>	Change in steady-state common-mode output voltage, V <sub>OC(H)</sub> - V <sub>OC(L)</sub> See Figure 1 and Figure 4	-0.1		0.1	V
V <sub>OC(PP)</sub>	Peak-to-peak common-mode output voltage, V <sub>OC(MAX)</sub> - V <sub>OC(MIN)</sub> R <sub>L</sub> = 54 Ω, C <sub>L</sub> = 50 pF, See Figure 1 and Figure 4		0.35		V
V <sub>OD(RING)</sub>	Differential output voltage over and under shoot R <sub>L</sub> = 54 Ω, C <sub>L</sub> = 50 pF, See Figure 5			10%	
I <sub>I</sub>	Input current D, DE	-100		100	μA
I <sub>O(OFF)</sub>	Output current with power off V <sub>CC</sub> <= 2.5 V	See receiver line input current			
I <sub>OZ</sub>	High impedance state output current DE at 0 V				
I <sub>OS</sub>	Short-circuit output current V <sub>O</sub> = -20 V to 25 V, See Figure 9	-250		250	mA
C <sub>OD</sub>	Differential output capacitance	See receiver C <sub>I</sub>			

<sup>(1)</sup> All typical values are at V<sub>CC</sub> = 5 V and 25°C.

## DRIVER SWITCHING CHARACTERISTICS

over recommended operating conditions (unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	TYP <sup>(1)</sup>	MAX	UNIT
t <sub>PLH</sub>	Differential output propagation delay, low-to- high R <sub>L</sub> = 54 Ω, C <sub>L</sub> = 50 pF, See Figure 3	6	10	20	ns
t <sub>PHL</sub>	Differential output propagation delay, high-to-low HVD21, HVD24	20	32	60	
	HVD22	160	280	500	
t <sub>r</sub>	Differential output rise time R <sub>L</sub> = 54 Ω, C <sub>L</sub> = 50 pF, See Figure 3	2	6	12	ns
t <sub>f</sub>	Differential output fall time HVD21, HVD24	20	40	60	
	HVD22	200	400	600	
t <sub>PZH</sub>	Propagation delay time, high-impedance-to-high-level output RE at 0 V, See Figure 6			40	ns
t <sub>PHZ</sub>	Propagation delay time, high-level-output-to-high-impedance HVD21, HVD24			100	
	HVD22			300	
t <sub>PZL</sub>	Propagation delay time, high-impedance-to-low-level output RE at 0 V, See Figure 7			40	ns
t <sub>PLZ</sub>	Propagation delay time, low-level-output-to-high-impedance HVD21, HVD24			100	
	HVD22			300	
t <sub>d(standby)</sub>	Time from an active differential output to standby RE at V <sub>CC</sub> , See Figure 8			2	μs
t <sub>d(wake)</sub>	Wake-up time from standby to an active differential output			8	μs
t <sub>sk(p)</sub>	Pulse skew   t <sub>PLH</sub> - t <sub>PHL</sub>   HVD20, HVD23			2	ns
	HVD21, HVD24			6	
	HVD22			50	

<sup>(1)</sup> All typical values are at V<sub>CC</sub> = 5 V and 25°C.

## RECEIVER ELECTRICAL CHARACTERISTICS

over recommended operating conditions

PARAMETER		TEST CONDITIONS		MIN	TYP <sup>(1)</sup>	MAX	UNIT
V <sub>IT(+)</sub>	Positive-going differential input voltage threshold	See Figure 10	V <sub>O</sub> = 2.4 V, I <sub>O</sub> = –8 mA		60	200	mV
V <sub>IT(–)</sub>	Negative-going differential input voltage threshold		V <sub>O</sub> = 0.4 V, I <sub>O</sub> = 8 mA	–200	–60		
V <sub>HYS</sub>	Hysteresis voltage (V <sub>IT+</sub> – V <sub>IT–</sub> )			100	130		mV
V <sub>IT(F+)</sub>	Positive-going differential input failsafe voltage threshold	See Figure 15	V <sub>CM</sub> = –7 V to 12 V	40	120	200	mV
			V <sub>CM</sub> = –20 V to 25 V		120	250	
V <sub>IT(F–)</sub>	Negative-going differential input failsafe voltage threshold	See Figure 15	V <sub>CM</sub> = –7 V to 12 V	–200	–120	–40	mV
			V <sub>CM</sub> = –20 V to 25 V	–250	–120		
V <sub>IK</sub>	Input clamp voltage	I <sub>I</sub> = –18 mA		–1.5			V
V <sub>OH</sub>	High-level output voltage	V <sub>ID</sub> = 200 mV, I <sub>OH</sub> = –8 mA, See Figure 11		4			V
V <sub>OL</sub>	Low-level output voltage	V <sub>ID</sub> = –200 mV, I <sub>OL</sub> = 8 mA, See Figure 11				0.4	V
I <sub>I</sub> (BUS)	Bus input current (power on or power off)	V <sub>I</sub> = –7 to 12 V, Other input = 0 V	HVD20, HVD23	–400		500	μA
			HVD21, HVD22, HVD24	–100		125	
		V <sub>I</sub> = –20 to 25 V, Other input = 0 V	HVD20, HVD23	–800		1000	
			HVD21, HVD22, HVD24	–200		250	
I <sub>I</sub>	Input current	RE		–100		100	μA
R <sub>I</sub>	Input resistance	HVD20, 23		24			kΩ
		HVD21, 22, 24		96			
C <sub>ID</sub>	Differential input capacitance	V <sub>ID</sub> = 0.5 + 0.4 sine (2π × 1.5 × 10 <sup>6</sup> t)				20	pF

(1) All typical values are at 25°C.

## RECEIVER SWITCHING CHARACTERISTICS

over recommended operating conditions

PARAMETER		TEST CONDITIONS		MIN	TYP	MAX	UNIT
t <sub>PLH</sub>	Propagation delay time, low-to-high level output	See Figure 11	HVD20, HVD23		16	35	ns
t <sub>PHL</sub>	Propagation delay time, high-to-low level output		HVD21, HVD22, HVD24		25	50	
t <sub>r</sub>	Receiver output rise time	See Figure 11			2	4	ns
t <sub>f</sub>	Receiver output fall time						
t <sub>PZH</sub>	Receiver output enable time to high level	See Figure 12			90	120	ns
t <sub>PHZ</sub>	Receiver output disable time from high level				16	35	
t <sub>PZL</sub>	Receiver output enable time to low level	See Figure 13			90	120	ns
t <sub>PLZ</sub>	Receiver output disable time from low level				16	35	
t <sub>r(standby)</sub>	Time from an active receiver output to standby	See Figure 14, DE at 0 V				2	μs
t <sub>r(wake)</sub>	Wake-up time from standby to an active receiver output					8	
t <sub>sk(p)</sub>	Pulse skew   t <sub>PLH</sub> – t <sub>PHL</sub>					5	ns
t <sub>p(set)</sub>	Delay time, bus fail to failsafe set	See Figure 15, pulse rate = 1 kHz			250	350	μs
t <sub>p(reset)</sub>	Delay time, bus recovery to failsafe reset					50	ns

## RECEIVER EQUALIZATION CHARACTERISTICS<sup>(1)</sup>

over recommended operating conditions

PARAMETER		TEST CONDITIONS				MIN	TYP <sup>(2)</sup>	MAX	UNIT
$t_{j(pp)}$	Peak-to-peak eye-pattern jitter	Pseudo-random NRZ code with a bit pattern length of $2^{16} - 1$ , Belden 3105A cable, See Figure 27	25 Mbps	0 m	HVD23		2		ns
				100 m	HVD20		6		
					HVD23		3		
				150 m	HVD20		15		
					HVD23		4		
				200 m	HVD20		27		
					HVD23		8		
			10 Mbps	200 m	HVD20		22		
					HVD23		8		
				250 m	HVD20		34		
					HVD23		15		
				300 m	HVD20		49		
					HVD23		27		
			5 Mbps	500 m	HVD21		128		
					HVD24		18		
			3 Mbps	500 m	HVD20		93		
					HVD21		103		
					HVD23		90		
					HVD24		16		
			1 Mbps	1000 m	HVD21		216		
					HVD24		62		

(1) The HVD20 and HVD21 do not have receiver equalization, but are specified for comparison.

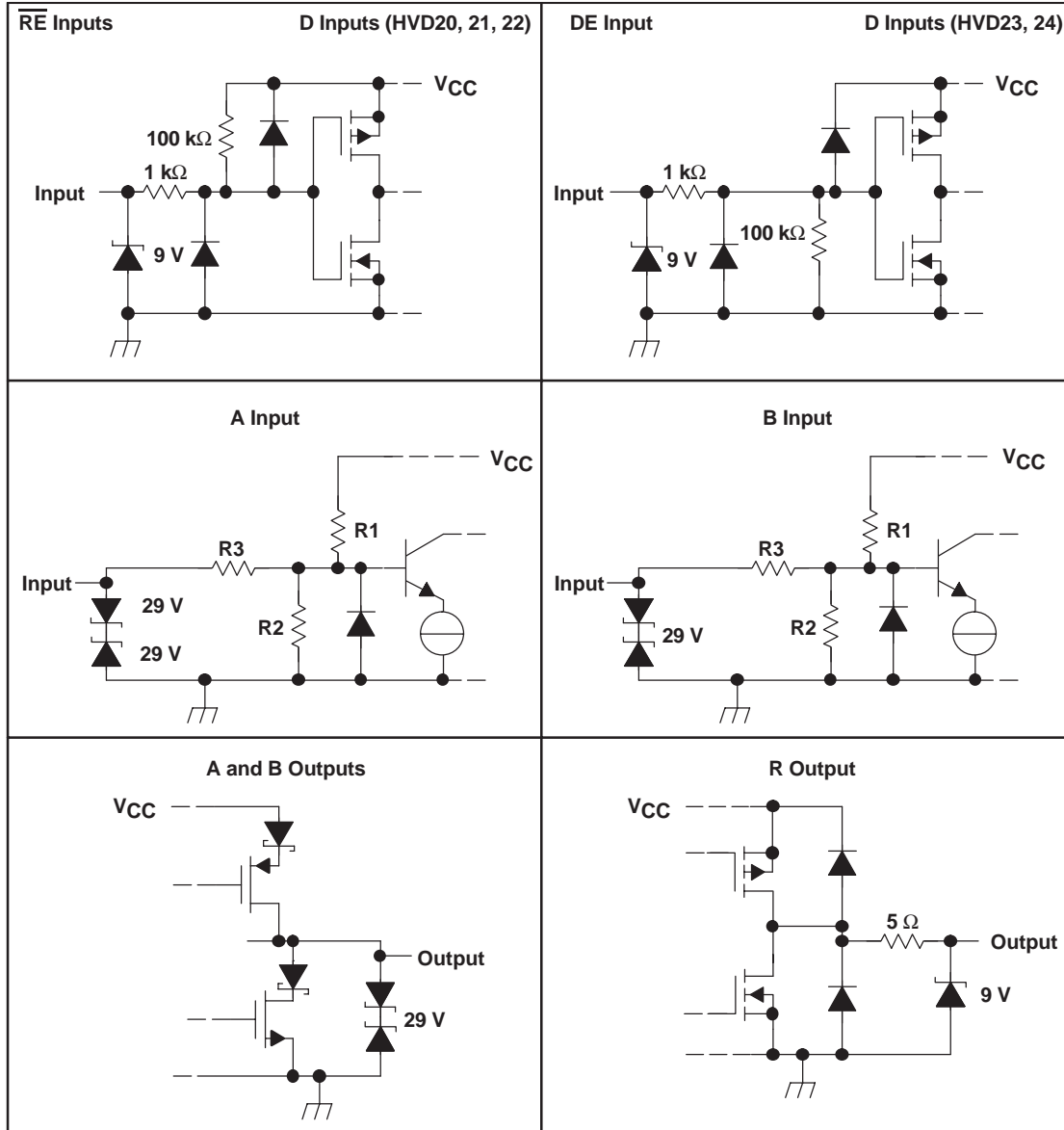
(2) All typical values are at  $V_{CC} = 5\text{ V}$ , and temperature =  $25^{\circ}\text{C}$ .

## SUPPLY CURRENT

over recommended operating conditions (unless otherwise noted)

PARAMETER		TEST CONDITIONS			MIN	TYP	MAX	UNIT
$I_{CC}$	Supply current	Driver enabled (DE at $V_{CC}$ ), Receiver enabled (RE at 0 V) No load, $V_I = 0\text{ V}$ or $V_{CC}$	HVD20		6	9		mA
			HVD21		8	12		
			HVD22		6	9		
			HVD23		7	11		
			HVD24		10	14		
		Driver enabled (DE at $V_{CC}$ ), Receiver disabled (RE at $V_{CC}$ ) No load, $V_I = 0\text{ V}$ or $V_{CC}$	HVD20		5	8		mA
			HVD21		7	11		
			HVD22		5	8		
			HVD23		5	9		
			HVD24		8	12		
		Driver disabled (DE at 0 V), Receiver enabled (RE at 0 V) No load	HVD20		4	7		mA
			HVD21		5	8		
			HVD22		4	7		
			HVD23		4.5	9		
			HVD24		5.5	10		
		Driver disabled (DE at 0 V), Receiver disabled (RE at $V_{CC}$ ) D open	All HVD2x				1	$\mu\text{A}$

## EQUIVALENT INPUT AND OUTPUT SCHEMATIC DIAGRAMS



	R1/R2	R3
HVD20, 23	9 kΩ	45 kΩ
HVD21, 22, 24	36 kΩ	180 kΩ



## PARAMETER MEASUREMENT INFORMATION

### NOTES:

Test load capacitance includes probe and jig capacitance (unless otherwise specified).

Signal generator characteristics: rise and fall time < 6 ns, pulse rate 100 kHz, 50% duty cycle,  $Z_0 = 50 \Omega$  (unless otherwise specified)

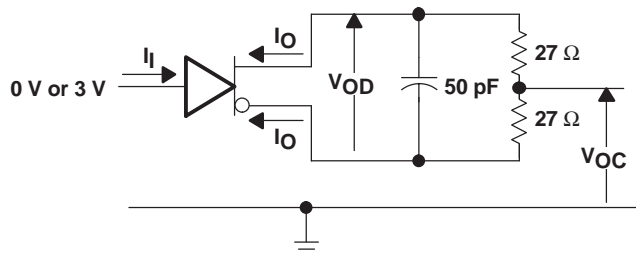


Figure 1. Driver Test Circuit,  $V_{OD}$  and  $V_{OC}$  Without Common-Mode Loading

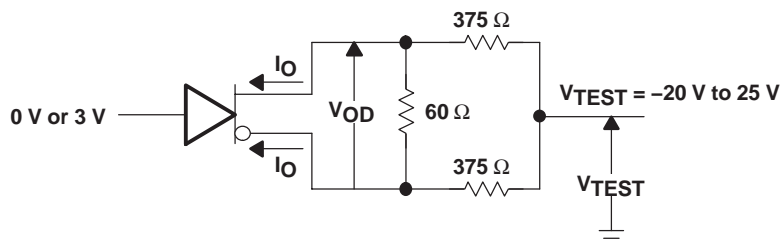


Figure 2. Driver Test Circuit,  $V_{OD}$  With Common-Mode Loading

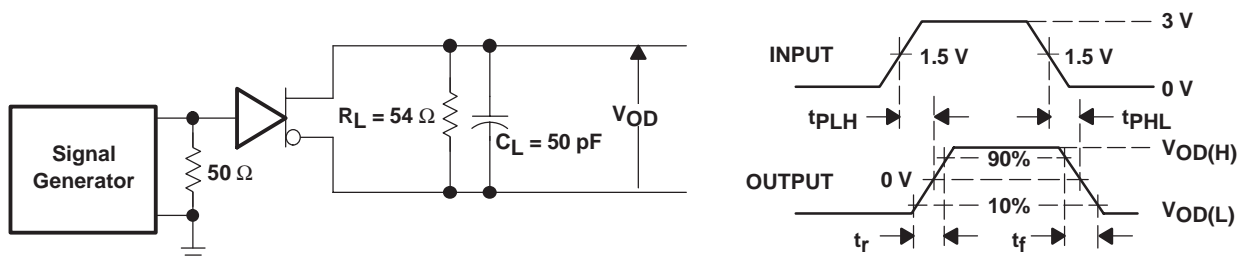


Figure 3. Driver Switching Test Circuit and Waveforms

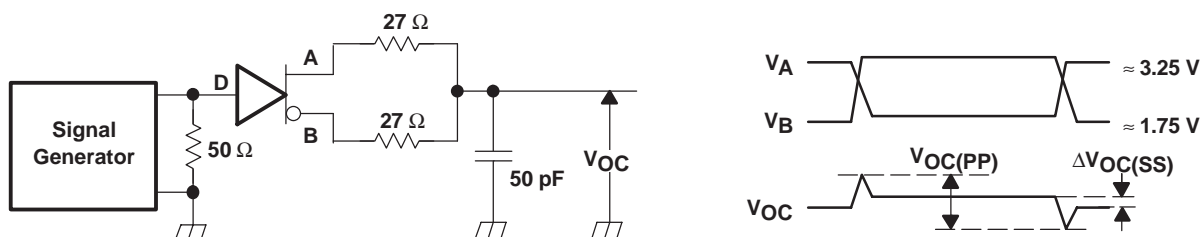
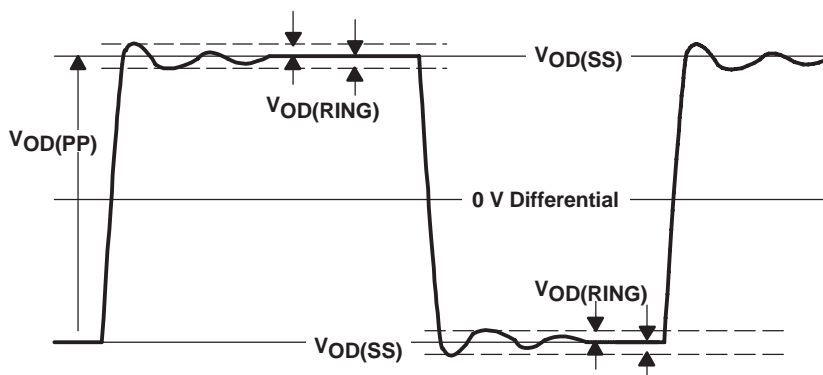


Figure 4. Driver  $V_{OC}$  Test Circuit and Waveforms



NOTE:  $V_{OD(RING)}$  is measured at four points on the output waveform, corresponding to overshoot and undershoot from the  $V_{OD(H)}$  and  $V_{OD(L)}$  steady state values.

Figure 5.  $V_{OD(RING)}$  Waveform and Definitions

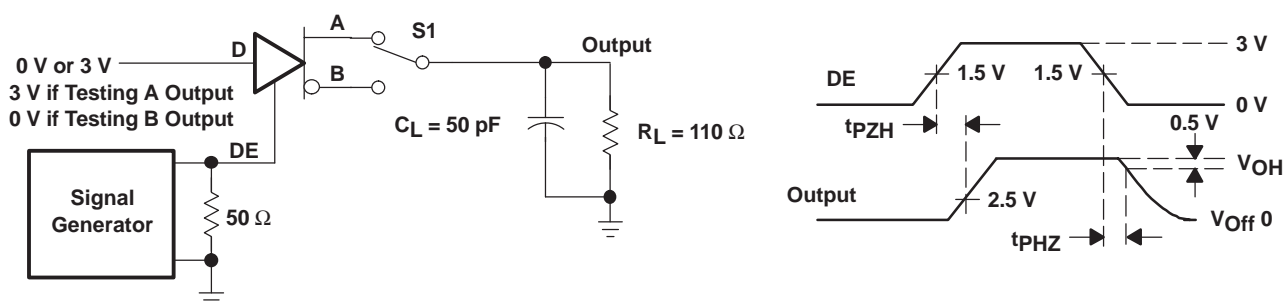


Figure 6. Driver Enable/Disable Test, High Output

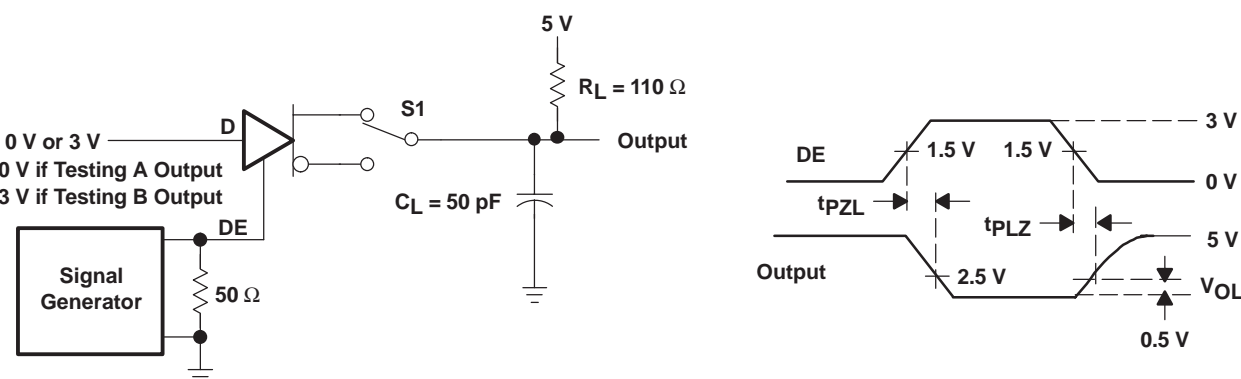


Figure 7. Driver Enable/Disable Test, Low Output

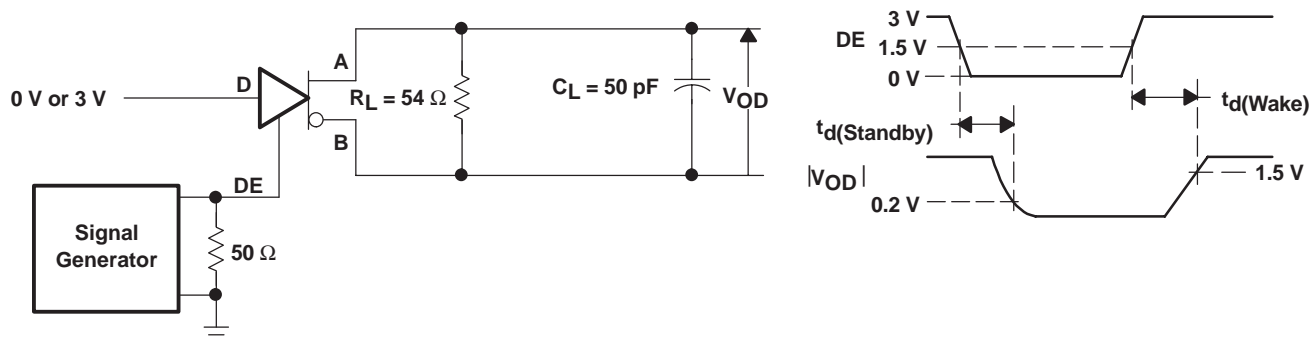


Figure 8. Driver Standby/Wake Test Circuit and Waveforms

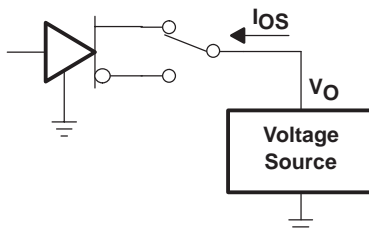


Figure 9. Driver Short-Circuit Test

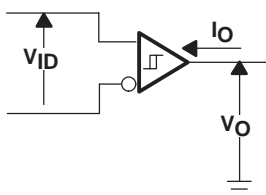


Figure 10. Receiver DC Parameter Definitions

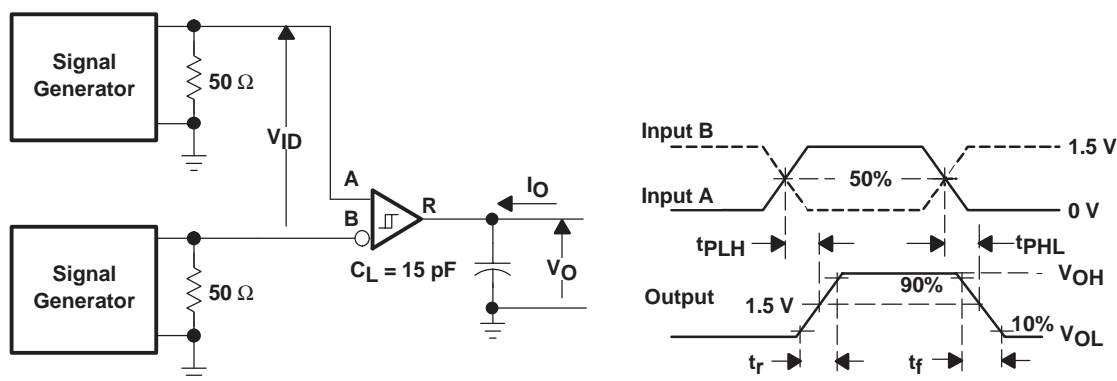


Figure 11. Receiver Switching Test Circuit and Waveforms

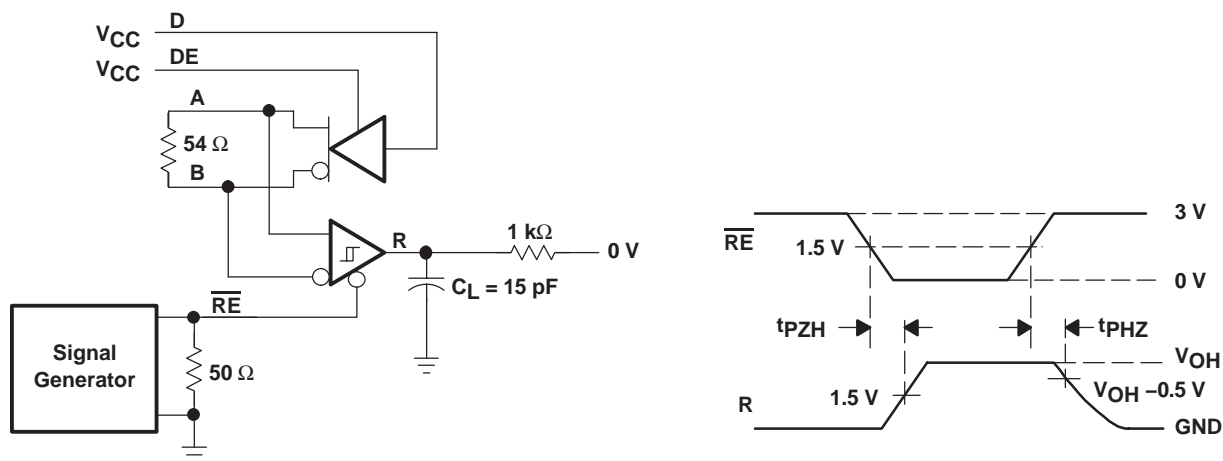


Figure 12. Receiver Enable Test Circuit and Waveforms, Data Output High

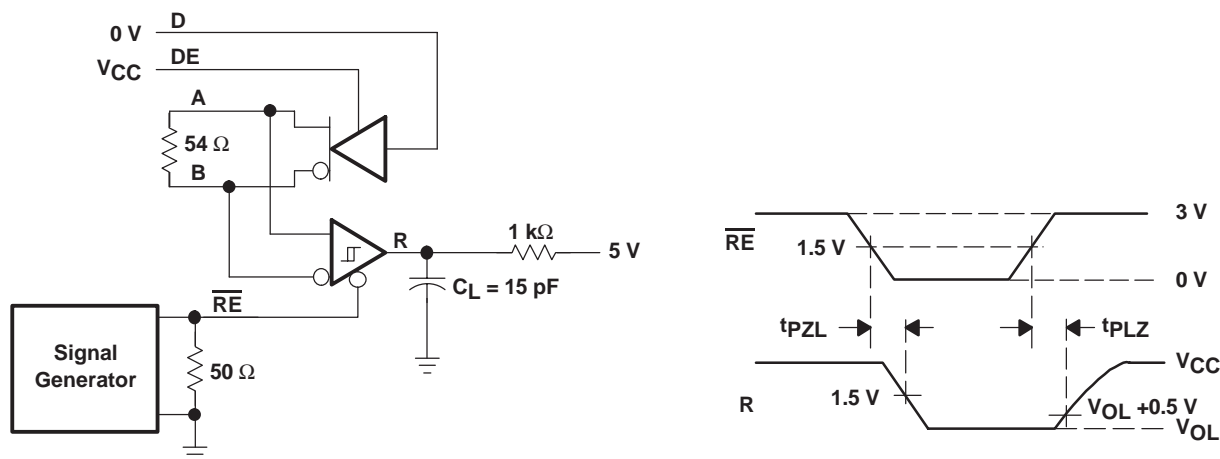


Figure 13. Receiver Enable Test Circuit and Waveforms, Data Output Low

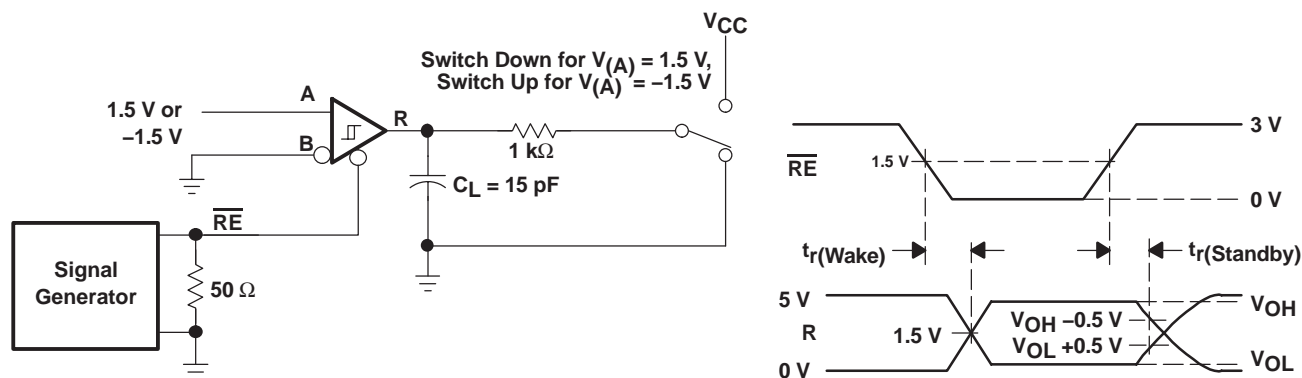


Figure 14. Receiver Standby and Wake Test Circuit and Waveforms

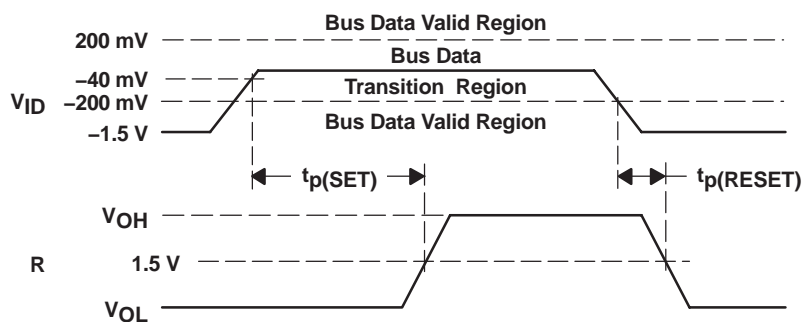


Figure 15. Receiver Active Failsafe Definitions and Waveforms

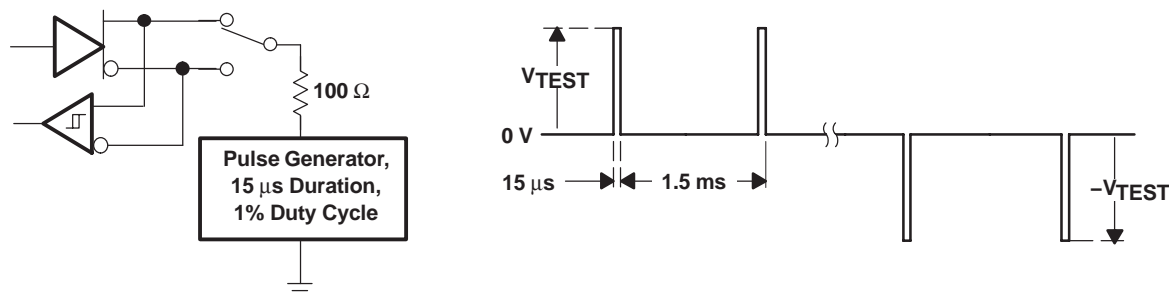
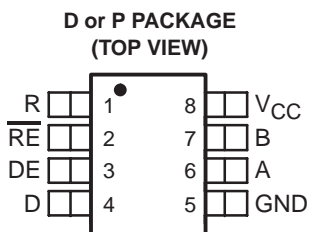


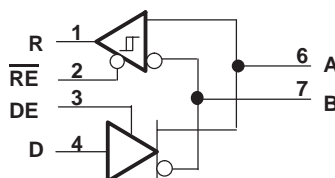
Figure 16. Test Circuit and Waveforms, Transient Overvoltage Test

## PIN ASSIGNMENTS



## LOGIC DIAGRAM

### POSITIVE LOGIC



## TYPICAL CHARACTERISTICS

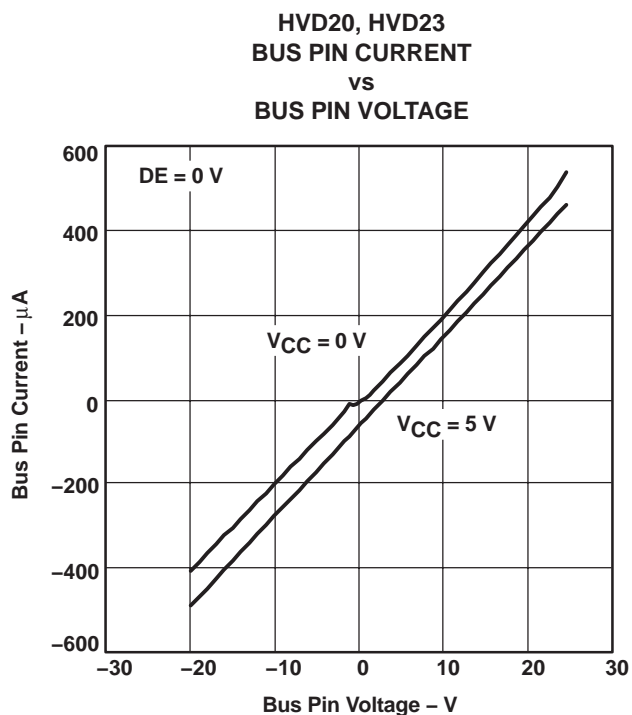


Figure 17

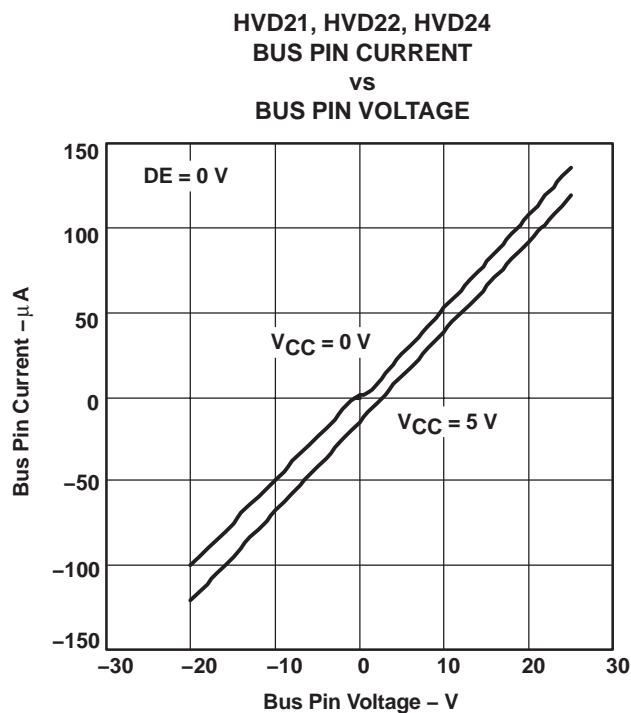


Figure 18

SUPPLY CURRENT  
vs  
SIGNALING RATE

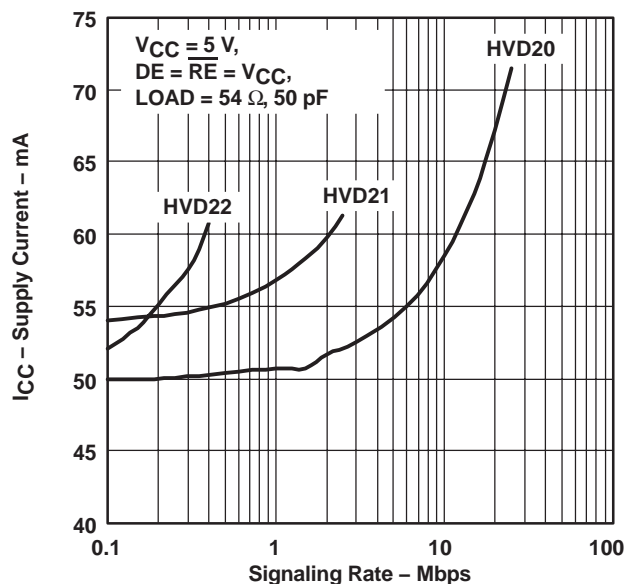


Figure 19

DRIVER DIFFERENTIAL OUTPUT VOLTAGE  
vs  
DRIVER LOAD CURRENT

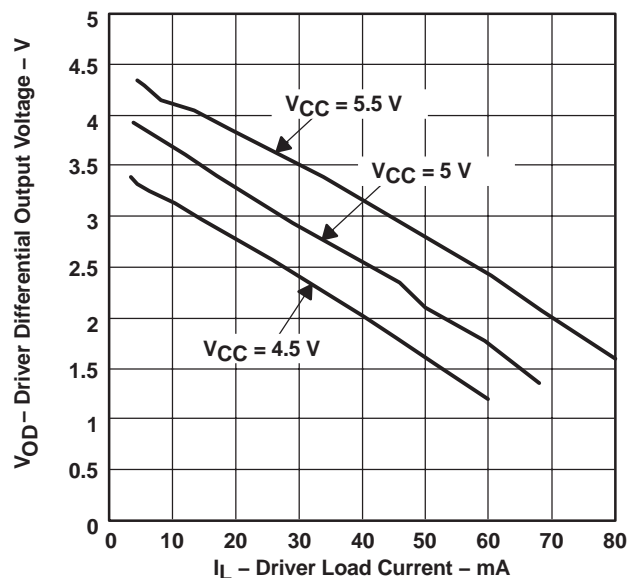


Figure 20

RECEIVER OUTPUT VOLTAGE  
vs  
DIFFERENTIAL INPUT VOLTAGE

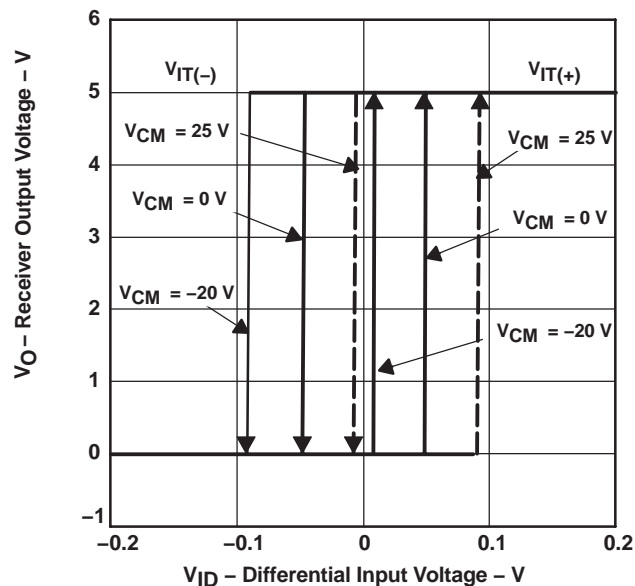


Figure 21

HVD20, HVD23  
PEAK-TO-PEAK JITTER  
vs  
CABLE LENGTH

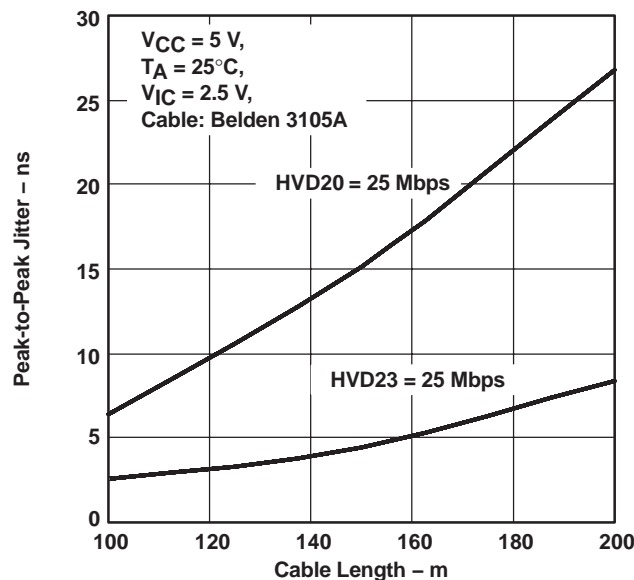


Figure 22

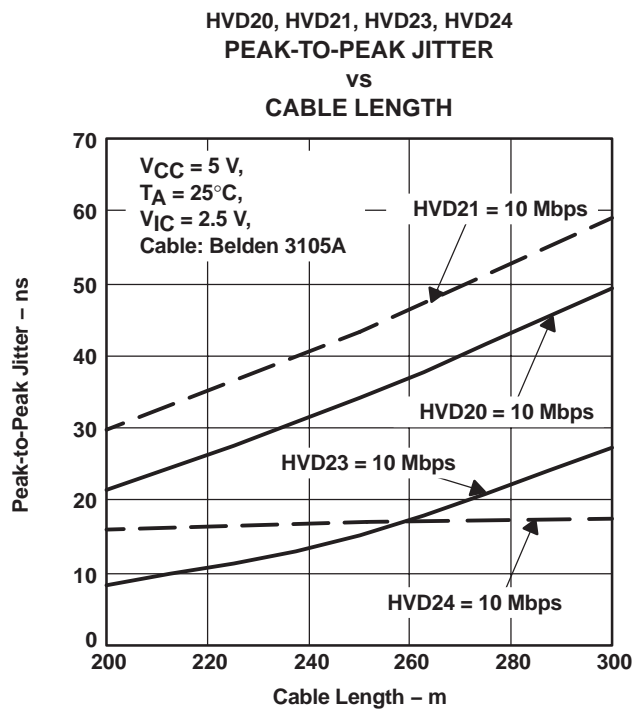


Figure 23

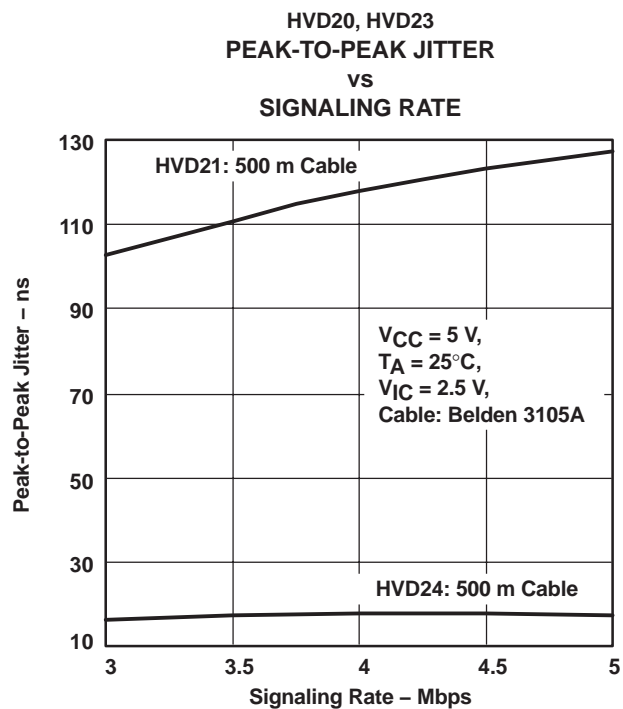
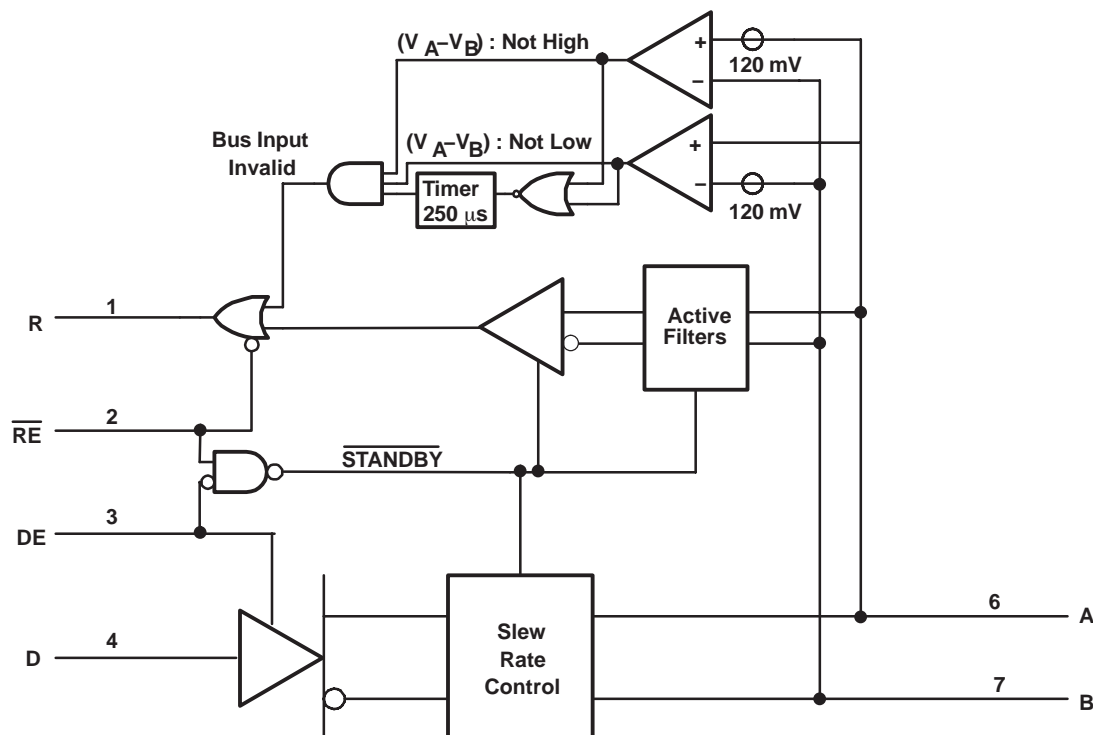


Figure 24

In addition to the primary differential receiver, these devices incorporate a set of comparators and logic to implement an active receiver failsafe feature. These components determine whether the differential bus signal is valid. Whenever the differential signal is close to zero volts (neither high nor low), a timer initiates. If the differential input remains within the transition range for more than 250 microseconds, the timer expires and sets the receiver output to the high state. If a valid bus input (high or low) is received at any time, the receiver output reflects the valid bus state, and the timer is reset.



### Figure 25. Function Block Diagram





### Figure 27. Cable Attenuation Model for Jitter Measurements

## INTEGRATED RECEIVER EQUALIZATION USING THE HVD23

Figure 28 illustrates the benefits of integrated receiver equalization as implemented in the HVD23 transceiver. In this test setup, a differential signal generator applied a signal voltage at one end of the cable, which was Belden 3105A twisted-pair shielded cable. The test signal was a pseudo-random bit stream (PRBS) of nonreturn-to-zero (NRZ) data. Channel 1 (top) shows the eye-pattern of the differential voltage at the receiver inputs (after the cable attenuation). Channel 2 (bottom) shows the output of the receiver.

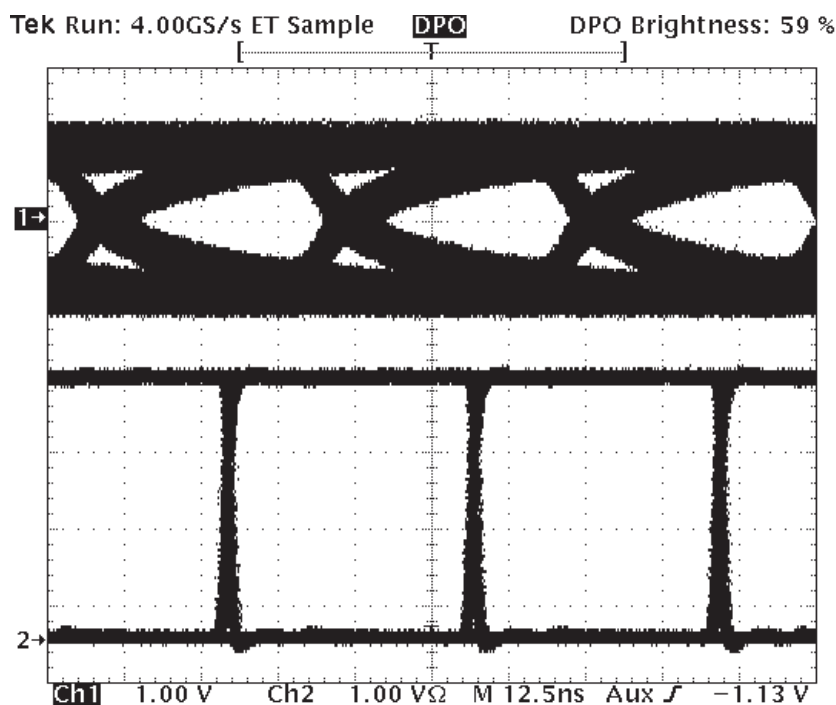


Figure 28. HVD23 Receiver Performance at 25 Mbps Over 150 Meter Cable

## INTEGRATED RECEIVER EQUALIZATION USING THE HVD24

Figure 29 illustrates the benefits of integrated receiver equalization as implemented in the HVD24 transceiver. In this test setup, a differential signal generator applied a signal voltage at one end of the cable, which was Belden 3105A twisted-pair shielded cable. The test signal was a pseudo-random bit stream (PRBS) of nonreturn-to-zero (NRZ) data. Channel 1 (top) shows the eye-pattern of the bit stream. Channel 2 (middle) shows the eye-pattern of the differential voltage at the receiver inputs (after the cable attenuation). Channel 3 (bottom) shows the output of the receiver.

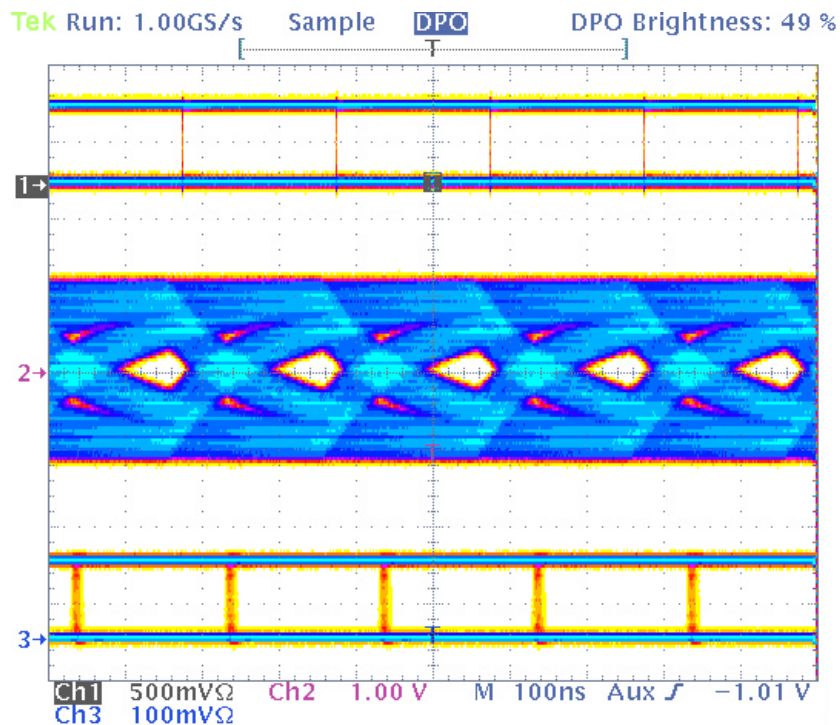


Figure 29. HVD24 Receiver Performance at 5 Mbps Over 500 Meter Cable

## **NOISE CONSIDERATIONS FOR EQUALIZED RECEIVERS**

The simplest way of overcoming the effects of cable losses is to increase the sensitivity of the receiver. If the maximum attenuation of frequencies of interest is 20 dB, increasing the receiver gain by a factor of ten compensates for the cable. However, this means that both signal and noise are amplified. Therefore, the receiver with higher gain is more sensitive to noise and it is important to minimize differential noise coupling to the equalized receiver.

Differential noise is created when conducted or radiated noise energy generates more voltage on one line of the differential pair than the other. For this to occur from conducted or electric far-field noise, the impedance to ground of the lines must differ.

For noise frequency out to 50 MHz, the input traces can be treated as a lumped capacitance if the receiver is approximately 10 inches or less from the connector. Therefore, matching impedance of the lines is accomplished by matching the lumped capacitance of each.

The primary factors that affect the capacitance of a trace are in length, thickness, width, dielectric material, distance from the signal return path, stray capacitance, and proximity to other conductors. It is difficult to match each of the variables for each line of the differential pair exactly, but a reasonable effort to do so keeps the lines balanced and less susceptible to differential noise coupling.

Another source of differential noise is from near-field coupling. In this situation, an assumption of equal noise-source impedance cannot be made as in the far-field. Familiarly known as crosstalk, more energy from a nearby signal is coupled to one line of the differential pair. Minimization of this differential noise is accomplished by keeping the signal pair close together and physical separation from high-voltage, high-current, or high-frequency signals.

In summary, follow these guidelines in board layout for keeping differential noise to a minimum.

- Keep the differential input traces short.
- Match the length, physical dimensions, and routing of each line of the pair.
- Keep the lines close together.
- Match components connected to each line.
- Separate the inputs from high-voltage, high-frequency, or high-current signals.

**PACKAGING INFORMATION**

Orderable Device	Status <sup>(1)</sup>	Package Type	Package Drawing	Pins	Package Qty	Eco Plan <sup>(2)</sup>	Lead/Ball Finish	MSL Peak Temp <sup>(3)</sup>
SN65HVD20D	ACTIVE	SOIC	D	8	75	TBD	CU NIPDAU	Level-1-220C-UNLIM
SN65HVD20DR	ACTIVE	SOIC	D	8	2500	TBD	CU NIPDAU	Level-1-220C-UNLIM
SN65HVD20P	ACTIVE	PDIP	P	8	50	Pb-Free (RoHS)	CU NIPDAU	Level-NC-NC-NC
SN65HVD21D	ACTIVE	SOIC	D	8	75	TBD	CU NIPDAU	Level-1-220C-UNLIM
SN65HVD21DR	ACTIVE	SOIC	D	8	2500	TBD	CU NIPDAU	Level-1-220C-UNLIM
SN65HVD21P	ACTIVE	PDIP	P	8	50	Pb-Free (RoHS)	CU NIPDAU	Level-NC-NC-NC
SN65HVD22D	ACTIVE	SOIC	D	8	75	TBD	CU NIPDAU	Level-1-220C-UNLIM
SN65HVD22DR	ACTIVE	SOIC	D	8	2500	TBD	CU NIPDAU	Level-1-220C-UNLIM
SN65HVD22P	ACTIVE	PDIP	P	8	50	Pb-Free (RoHS)	CU NIPDAU	Level-NC-NC-NC
SN65HVD22PE4	ACTIVE	PDIP	P	8	50	Pb-Free (RoHS)	CU NIPDAU	Level-NC-NC-NC
SN65HVD23D	ACTIVE	SOIC	D	8	75	TBD	CU NIPDAU	Level-1-220C-UNLIM
SN65HVD23DR	ACTIVE	SOIC	D	8	2500	TBD	CU NIPDAU	Level-1-220C-UNLIM
SN65HVD23P	ACTIVE	PDIP	P	8	50	Pb-Free (RoHS)	CU NIPDAU	Level-NC-NC-NC
SN65HVD23PE4	ACTIVE	PDIP	P	8	50	Pb-Free (RoHS)	CU NIPDAU	Level-NC-NC-NC
SN65HVD24D	ACTIVE	SOIC	D	8	75	TBD	CU NIPDAU	Level-1-220C-UNLIM
SN65HVD24DR	ACTIVE	SOIC	D	8	2500	TBD	CU NIPDAU	Level-1-220C-UNLIM
SN65HVD24P	ACTIVE	PDIP	P	8	50	Pb-Free (RoHS)	CU NIPDAU	Level-NC-NC-NC
SN65HVD24PE4	ACTIVE	PDIP	P	8	50	Pb-Free (RoHS)	CU NIPDAU	Level-NC-NC-NC

<sup>(1)</sup> The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

**LIFEBUY:** TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

**NRND:** Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSELETE:** TI has discontinued the production of the device.

<sup>(2)</sup> Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS) or Green (RoHS & no Sb/Br) - please check <http://www.ti.com/productcontent> for the latest availability information and additional product content details.

**TBD:** The Pb-Free/Green conversion plan has not been defined.

**Pb-Free (RoHS):** TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

**Green (RoHS & no Sb/Br):** TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

<sup>(3)</sup> MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

**Important Information and Disclaimer:** The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on

incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

## P (R-PDIP-T8)

## PLASTIC DUAL-IN-LINE



NOTES: A. All linear dimensions are in inches (millimeters).  
 B. This drawing is subject to change without notice.  
 C. Falls within JEDEC MS-001

For the latest package information, go to [http://www.ti.com/sc/docs/package/pkg\\_info.htm](http://www.ti.com/sc/docs/package/pkg_info.htm)

## D (R-PDSO-G8)

## PLASTIC SMALL-OUTLINE PACKAGE



- NOTES:
- A. All linear dimensions are in inches (millimeters).
  - B. This drawing is subject to change without notice.
  - C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).
  - D. Falls within JEDEC MS-012 variation AA.



## IMPORTANT NOTICE

Texas Instruments Incorporated and its subsidiaries (TI) reserve the right to make corrections, modifications, enhancements, improvements, and other changes to its products and services at any time and to discontinue any product or service without notice. Customers should obtain the latest relevant information before placing orders and should verify that such information is current and complete. All products are sold subject to TI's terms and conditions of sale supplied at the time of order acknowledgment.

TI warrants performance of its hardware products to the specifications applicable at the time of sale in accordance with TI's standard warranty. Testing and other quality control techniques are used to the extent TI deems necessary to support this warranty. Except where mandated by government requirements, testing of all parameters of each product is not necessarily performed.

TI assumes no liability for applications assistance or customer product design. Customers are responsible for their products and applications using TI components. To minimize the risks associated with customer products and applications, customers should provide adequate design and operating safeguards.

TI does not warrant or represent that any license, either express or implied, is granted under any TI patent right, copyright, mask work right, or other TI intellectual property right relating to any combination, machine, or process in which TI products or services are used. Information published by TI regarding third-party products or services does not constitute a license from TI to use such products or services or a warranty or endorsement thereof. Use of such information may require a license from a third party under the patents or other intellectual property of the third party, or a license from TI under the patents or other intellectual property of TI.

Reproduction of information in TI data books or data sheets is permissible only if reproduction is without alteration and is accompanied by all associated warranties, conditions, limitations, and notices. Reproduction of this information with alteration is an unfair and deceptive business practice. TI is not responsible or liable for such altered documentation.

Resale of TI products or services with statements different from or beyond the parameters stated by TI for that product or service voids all express and any implied warranties for the associated TI product or service and is an unfair and deceptive business practice. TI is not responsible or liable for any such statements.

Following are URLs where you can obtain information on other Texas Instruments products and application solutions:

<b>Products</b>		<b>Applications</b>	
Amplifiers	<a href="http://amplifier.ti.com">amplifier.ti.com</a>	Audio	<a href="http://www.ti.com/audio">www.ti.com/audio</a>
Data Converters	<a href="http://dataconverter.ti.com">dataconverter.ti.com</a>	Automotive	<a href="http://www.ti.com/automotive">www.ti.com/automotive</a>
DSP	<a href="http://dsp.ti.com">dsp.ti.com</a>	Broadband	<a href="http://www.ti.com/broadband">www.ti.com/broadband</a>
Interface	<a href="http://interface.ti.com">interface.ti.com</a>	Digital Control	<a href="http://www.ti.com/digitalcontrol">www.ti.com/digitalcontrol</a>
Logic	<a href="http://logic.ti.com">logic.ti.com</a>	Military	<a href="http://www.ti.com/military">www.ti.com/military</a>
Power Mgmt	<a href="http://power.ti.com">power.ti.com</a>	Optical Networking	<a href="http://www.ti.com/opticalnetwork">www.ti.com/opticalnetwork</a>
Microcontrollers	<a href="http://microcontroller.ti.com">microcontroller.ti.com</a>	Security	<a href="http://www.ti.com/security">www.ti.com/security</a>
		Telephony	<a href="http://www.ti.com/telephony">www.ti.com/telephony</a>
		Video & Imaging	<a href="http://www.ti.com/video">www.ti.com/video</a>
		Wireless	<a href="http://www.ti.com/wireless">www.ti.com/wireless</a>

Mailing Address: Texas Instruments  
Post Office Box 655303 Dallas, Texas 75265

Copyright © 2005, Texas Instruments Incorporated

Copyright © Each Manufacturing Company.

All Datasheets cannot be modified without permission.

This datasheet has been download from :

[www.AllDataSheet.com](http://www.AllDataSheet.com)

100% Free DataSheet Search Site.

Free Download.

No Register.

Fast Search System.

[www.AllDataSheet.com](http://www.AllDataSheet.com)